

Notice of References Cited	Application/Control No. 10/558,432	Applicant(s)/Patent Under Reexamination BAEK ET AL.	
	Examiner CHRISTOPHER T. WYLLIE	Art Unit 2619	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,519,858 A	05-1996	Walton et al.	707/10
*	B	US-2004/0088731 A1	05-2004	Putterman et al.	725/094
*	C	US-7,062,531 B2	06-2006	Kim, Seung-Cheon	709/203
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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